BUK7509-75A



N-channel TrenchMOS standard level FET Rev. 03 — 21 February 2011

Product data sheet

Product profile 1.

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- AEC Q101 compliant
- Low conduction losses due to low on-state resistance
- Suitable for standard level gate drive sources
- Suitable for thermally demanding environments due to 175 °C rating

1.3 Applications

- 12 V, 24 V and 42 V loads
- Automotive and general purpose power switching

Motors, lamps and solenoids

1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|--|---|-----|------|-----|------|
| V_{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | - | - | 75 | V |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u> | - | - | 75 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | - | - | 230 | W |
| Static chara | acteristics | | | | | |
| R _{DSon} | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 175 \text{ °C}; \text{ see } \frac{\text{Figure 12}}{\text{see } \frac{\text{Figure 13}}{\text{Figure 13}}}$ | 77 | 18.9 | mΩ | |
| | | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 12}}{\text{see Figure 13}};$ | - | 7.7 | 9 | mΩ |
| Avalanche | ruggedness | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | I_D = 75 A; $V_{sup} \le$ 75 V; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped | - | - | 560 | mJ |



2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|--------------------|----------------|
| 1 | G | gate | | _ |
| 2 | D | drain | mb | D |
| 3 | S | source | | |
| mb | D | mounting base; connected to drain | 1 2 3 | mbb076 S |
| | | | SOT78A (TO-220AB) | |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | | | |
|-------------|----------|--|---------|--|--|
| | Name | Description | Version | | |
| BUK7509-75A | TO-220AB | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB | SOT78A | | |

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|----------------------|--|--|-----|-----|------|
| V_{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | - | 75 | V |
| V_{DGR} | drain-gate voltage | $R_{GS} = 20 \text{ k}\Omega$ | - | 75 | V |
| V _{GS} | gate-source voltage | | -20 | 20 | V |
| I _D | drain current | T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u> | - | 75 | Α |
| | | $T_{mb} = 100 ^{\circ}\text{C}; V_{GS} = 10 \text{V}; \text{see} \frac{\text{Figure 1}}{}$ | - | 65 | Α |
| I _{DM} | peak drain current | T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$; see Figure 3 | - | 440 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | - | 230 | W |
| T _{stg} | storage temperature | | -55 | 175 | °C |
| Tj | junction temperature | | -55 | 175 | °C |
| Source-drain | diode | | | | |
| Is | source current | T _{mb} = 25 °C | - | 75 | Α |
| I _{SM} | peak source current | pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$ | - | 440 | Α |
| Avalanche rug | ggedness | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | I_D = 75 A; $V_{sup} \le$ 75 V; R_{GS} = 50 Ω; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped | - | 560 | mJ |

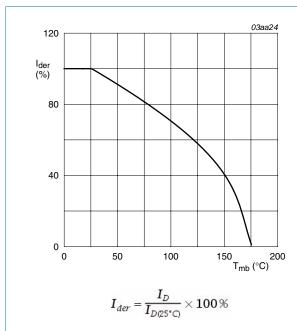


Fig 1. Normalized continuous drain current as a function of mounting base temperature

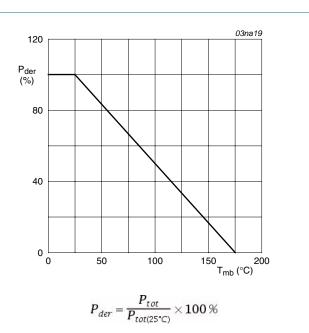
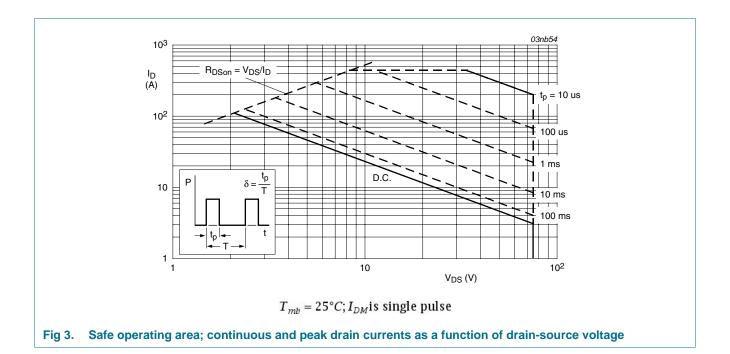


Fig 2. Normalized total power dissipation as a function of mounting base temperature



5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|---|-----------------------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see Figure 4 | - | - | 0.65 | K/W |
| R _{th(j-a)} | thermal resistance from junction to ambient | vertical in still air | - | 60 | - | K/W |

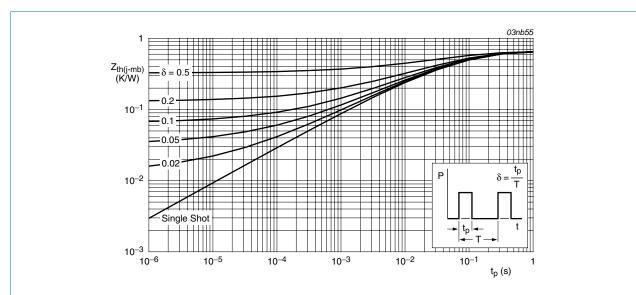


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|----------------------------------|--|-----|------|------|------|
| Static char | acteristics | | | | | |
| V _{(BR)DSS} | drain-source breakdown | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$ | 70 | - | - | V |
| | voltage | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | 75 | - | - | V |
| V _{GS(th)} | gate-source threshold voltage | $I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see Figure 11 | 1 | - | - | V |
| | | I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; see <u>Figure 11</u> | 2 | 3 | 4 | V |
| | | $I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = -55$ °C; see Figure 11 | - | - | 4.4 | V |
| I _{DSS} | drain leakage current | $V_{DS} = 75 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$ | - | - | 500 | μΑ |
| | | $V_{DS} = 75 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 0.05 | 10 | μΑ |
| I _{GSS} | gate leakage current | $V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 2 | 100 | nΑ |
| | | $V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 2 | 100 | nΑ |
| 500 | drain-source on-state resistance | V_{GS} = 10 V; I_D = 25 A; T_j = 175 °C; see <u>Figure 12</u> ; see <u>Figure 13</u> | - | - | 18.9 | mΩ |
| | | V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; see <u>Figure 12</u> ; see <u>Figure 13</u> | - | 7.7 | 9 | mΩ |
| Dynamic c | haracteristics | | | | | |
| C _{iss} | input capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$ | - | 5068 | 6760 | pF |
| C _{oss} | output capacitance | T _j = 25 °C; see <u>Figure 14</u> | - | 1082 | 1300 | pF |
| C _{rss} | reverse transfer capacitance | $V_{GS} = 0 \text{ V}; V_{DS} 25 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 14}{\text{ Colored}}$ | - | 620 | 850 | pF |
| td(on) | turn-on delay time | $V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V};$ | - | 35 | - | ns |
| r | rise time | $R_{G(ext)} = 10 \Omega; T_j = 25 \text{ °C}$ | - | 107 | - | ns |
| d(off) | turn-off delay time | | - | 183 | - | ns |
| i _f | fall time | | - | 100 | - | ns |
| L _D | internal drain inductance | from contact screw on mounting base to centre of die ; $T_j = 25$ °C | - | 3.5 | - | nΗ |
| | | from drain lead 6 mm from package to centre of die ; $T_j = 25 ^{\circ}\text{C}$ | - | 4.5 | - | nΗ |
| L-s | internal source inductance | from source lead to source bond pad; $T_j = 25$ °C | - | 7.5 | - | nΗ |
| Source-dra | ain diode | | | | | |
| V_{SD} | source-drain voltage | $I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 15</u> | - | 0.85 | 1.2 | V |
| rr | reverse recovery time | $I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$ | - | 75 | - | ns |
| Q _r | recovered charge | $V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$ | - | 270 | - | nC |

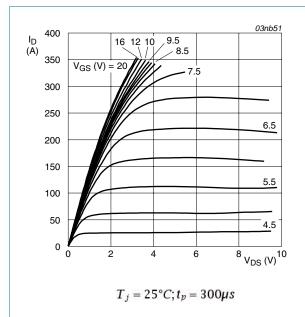


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

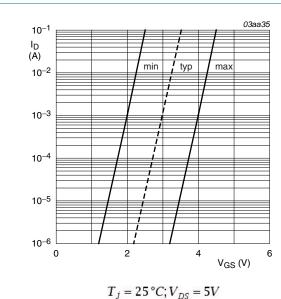
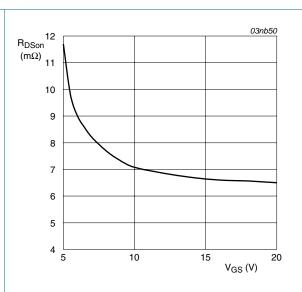
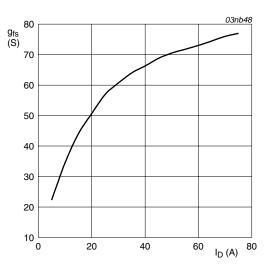


Fig 7. Sub-threshold drain current as a function of gate-source voltage



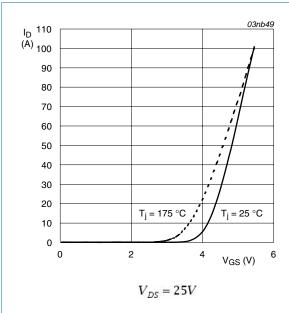
 $T_j=25^{\circ}C; I_D=25A$

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values

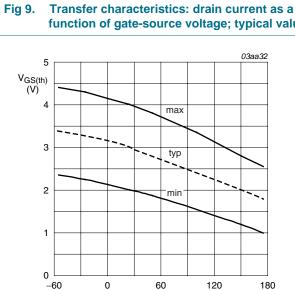


 $T_j = 25^{\circ}C; V_{DS} = 25V$

Fig 8. Forward transconductance as a function of drain current; typical values



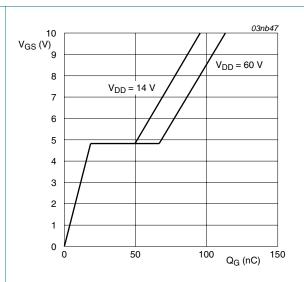
function of gate-source voltage; typical values



 $I_D = 1mA; V_{DS} = V_{GS}$

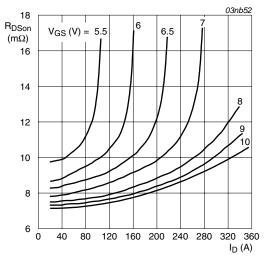
Fig 11. Gate-source threshold voltage as a function of junction temperature

T_i (°C)



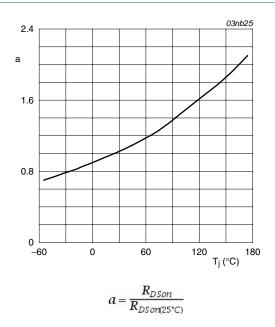
 $T_j = 25^{\circ}C; I_D = 25A$

Fig 10. Gate-source voltage as a function of turn-on gate charge; typical values



 $T_j = 25^{\circ}C$

Fig 12. Drain-source on-state resistance as a function of drain current; typical values



9000 C (pF) 8000 7000 6000 5000 4000 3000 2000 1000 0.01 0.1 V_{DS} (V) $V_{GS} = 0V; f = 1MHz$

Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature

Fig 14. Input, output and reverse capacitances as a function of drain-source voltage; typical values

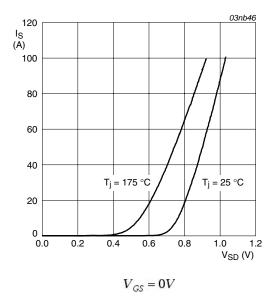


Fig 15. Reverse diode current as a function of reverse diode voltage; typical values

Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78A

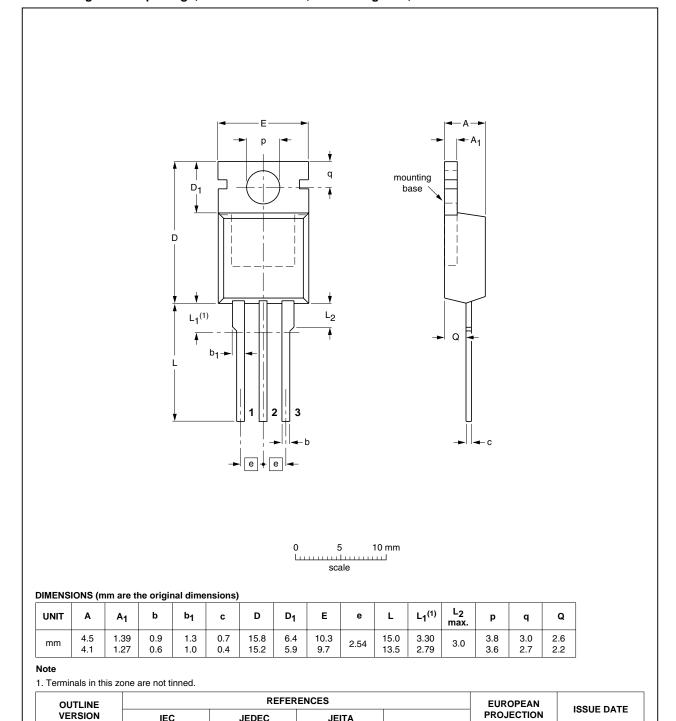


Fig 16. Package outline SOT78A (TO-220AB)

IEC

JEDEC

3-lead TO-220AB

JEITA

SC-46

03-01-22

05-03-14

SOT78A

8. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------------|--------------------------------------|--|---------------------|---------------------------|
| BUK7509-75A v.3 | 20110221 | Product data sheet | - | BUK7509_7609_75A v.2 |
| Modifications: | | this data sheet has been NXP Semiconductors. | redesigned to com | ply with the new identity |
| | Legal texts have | ave been adapted to the r | new company name | where appropriate. |
| | Type number | BUK7509-75A separated | d from data sheet B | UK7509_7609_75A v.2. |
| BUK7509_7609_75A v.2 | 20001106 | Product specification | - | BUK7509_7609_75A v.1 |

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|--------------------------------|--------------------|---|
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BUK7509-75A

N-channel TrenchMOS standard level FET

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